## Notice of References Cited Application/Control No. 10/576,965 Examiner BRYAN T. KILPATRICK Applicant(s)/Patent Under Reexamination HOSHINO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,388,627	06-2008	Hoshino et al.	349/96
*	В	US-2002/0051264	05-2002	SHIOZAWA et al.	359/2
*	С	US-4,761,543	08-1988	Hayden, Kenneth J.	235/457
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	EP 1028359 A1	08-2000	European Patent	SHIOZAWA et al.	
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.